

FS22SM-9-VB Datasheet

N-Channel 600 V (D-S) Super Junction MOSFET

PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	600				
R _{DS(on)} (Ω) at 25 °C	$V_{GS} = 10 V$	0.19			
Q _g max. (nC)	106				
Q _{gs} (nC)	14				
Q _{gd} (nC)	33				
Configuration	Single				

FEATURES

- Reduced t_{rr}, Q_{rr}, and I_{RRM}
- Low figure-of-merit (FOM) $R_{on} \times Q_g$
- Low input capacitance (C_{iss})
- Low switching losses due to reduced Q_{rr}
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Telecommunications
 - Server and telecom power supplies
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Consumer and computing
 - ATX power supplies
- Industrial
 - Welding
 - Battery chargers
- Renewable energy
- Solar (PV inverters)
- Switch mode power supplies (SMPS)

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G D S	D (TAB)
	S N-Channel MOSFET

= 25 °C, unless otherwis	se noted)			
PARAMETER			UNIT	
Drain-Source Voltage			v	
Gate-Source Voltage				
$T_{\rm C} = 25 ^{\circ}{\rm C}$	- I _D -	20		
$T_{\rm C} = 100 ^{\circ}{\rm C}$		13	А	
Pulsed Drain Current ^a				
Linear Derating Factor			W/°C	
Single Pulse Avalanche Energy ^b			mJ	
Maximum Power Dissipation			W	
Operating Junction and Storage Temperature Range			°C	
T _J = 125 °C	d\//dt	37	V/ns	
Reverse Diode dV/dt ^d			v/ns	
for 10 s		300	°C	
	V_{GS} at 10 V $T_{C} = 25 °C$ $T_{C} = 100 °C$ $T_{J} = 125 °C$	$\begin{tabular}{ c c c c c } & SYMBOL & & & & & & & & & & & & & & & & & & &$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50$ V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 5.1 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C.





THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 62				00.00		
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.5				°C/W		
SPECIFICATIONS ($T_J = 25 \text{ °C}$, u	Inless otherw	ise noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static	1				1	1	<u> </u>	1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D =	250 µA	600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.67	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D =	250 µA	2	-	4	V
		$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA	
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V		-	-	± 1	μA
Zero Gate Voltage Drain Current	l=	V _{DS} =	= 520 V, V _G	$a_{\rm S} = 0 \rm V$	-	-	1	μA
Zero Gate voltage Drain Current	IDSS	V _{DS} = 520 \	/, V _{GS} = 0 \	√, T _J = 125 °C	-	-	500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I	_D = 11 A	-	0.19	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D	= 11 A	-	7.0	-	S
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 V$	<i>'</i> .	-	2322	-	
Output Capacitance	C _{oss}		$V_{DS} = 100 V,$ f = 1 MHz		-	105	-	
Reverse Transfer Capacitance	C _{rss}				-	4	-	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	$V_{DS} = 0 V$ to 520 V, $V_{GS} = 0 V$		-	84	-	pF	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	293	-		
Total Gate Charge	Qg				-	71	106	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	$V_{GS} = 10 \text{ V}$ $I_D = 11 \text{ A}, V_{DS} = 520 \text{ V}$		-	14	-	nC
Gate-Drain Charge	Q _{gd}				-	33	-	
Turn-On Delay Time	t _{d(on)}				-	22	44	
Rise Time	t _r	V _{DD} = 520 V, I _D = 11 A,		-	34	68	ns	
Turn-Off Delay Time	t _{d(off)}	V _{GS} =	$V_{GS} = 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega$		-	68	102	115
Fall Time	t _f]		-	42	84		
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.78	-	Ω	
Drain-Source Body Diode Characteristic	cs	-						
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the	MOSFET symbol showing the		-	-	21	
Pulsed Diode Forward Current	I _{SM}	integral reverse p - n junction diode		-	-	53	A	
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 11 A, V _{GS} = 0 V		-	0.9	1.2	V	
Reverse Recovery Time	t _{rr}				-	160	-	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 11 \text{ A},$ dl/dt = 100 A/µs, V _R = 25 V		-	1.2	-	μC	
Reverse Recovery Current	I _{RRM}			-	14	-	A	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

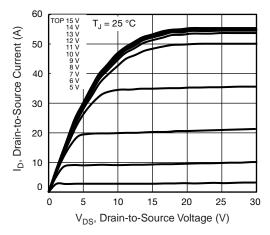


Fig. 1 - Typical Output Characteristics



Fig. 2 - Typical Output Characteristics

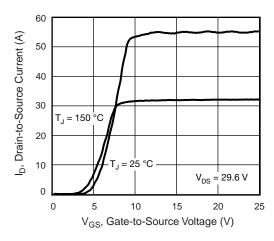


Fig. 3 - Typical Transfer Characteristics

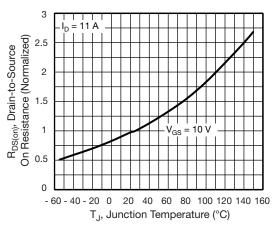


Fig. 4 - Normalized On-Resistance vs. Temperature

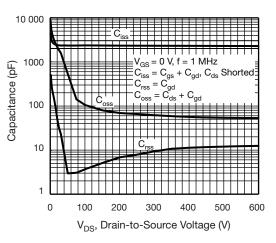


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

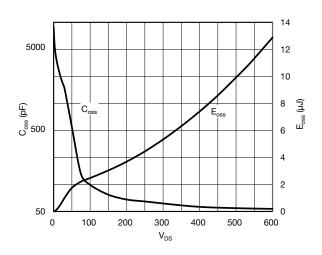


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



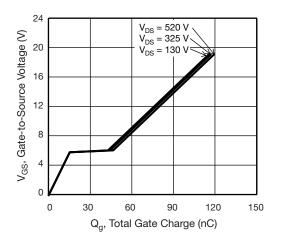


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

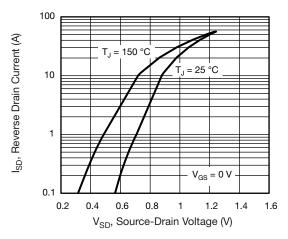


Fig. 8 - Typical Source-Drain Diode Forward Voltage

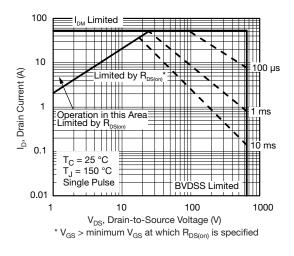


Fig. 9 - Maximum Safe Operating Area

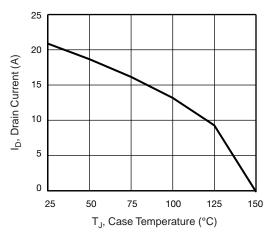


Fig. 10 - Maximum Drain Current vs. Case Temperature



Fig. 11 - Temperature vs. Drain-to-Source Voltage





Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case



Fig. 13 - Switching Time Test Circuit

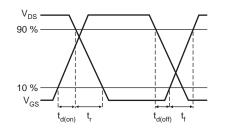


Fig. 14 - Switching Time Waveforms

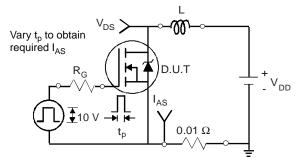


Fig. 15 - Unclamped Inductive Test Circuit

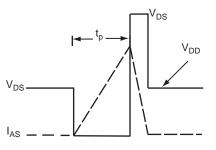


Fig. 16 - Unclamped Inductive Waveforms

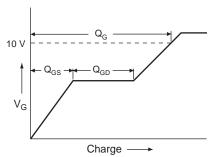
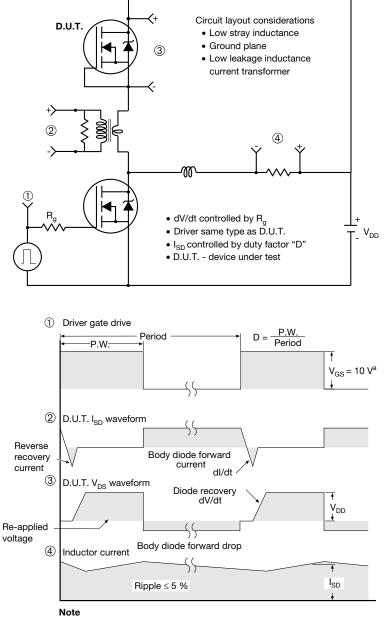


Fig. 17 - Basic Gate Charge Waveform





Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5$ V for logic level devices

Fig. 19 - For N-Channel



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